

















# MiNaPAD Forum 2024

1<sup>th</sup> Micro/Nano-Electronics Packaging and Assembly, Design and Manufacturing Forum EXHIBITION & C th GRENOBLE Organized by IMAPS - International Microelectronics Assembly and Packaging Society 17 rue de l'Amiral Hamelin - 75016 Paris - France Tel: +33 (0) 7 88 75 59 86

Media Sponsor: YOLE

imaps.france@orange.fr - www.france.imapseurope.org

# Wednesday June 19th



Welcome to MiNaPAD – Coffee & Soft drink sponsored by 8h15

Opening by Jean-Marc YANNOU (Auditorium) 9h00

9h10 Keynote: Mudasir AHMAD (IEEE - EPS Distinguished lecturer)

**Advanced Packaging for Artificial Intelligence Applications** 

9h45	SESSION A: AI Applications (Auditorium)  Detection and measurement of solder voids in X ray of led assembly with YOLO v8 (Yasser ALMEHIO, VALEO - France)	SESSION B: Attachment materials (Mont Blanc) The Application of Low Temperature Self-Assembly Sn Based Glue (Glenn LIN, ASE group - Taiwan)
10h15	Solder paste development using AI (Melanie MATHON, INVENTEC - France)	New Bare Copper Compatible Die Attach Developments Improving Reliability and Thermal at Lower Cost (Ruud De WIT, HENKEL – The Netherlands)

## 10h45 – 11h15 Exhibition Opening (Exhibition Hall) / Coffee break sponsored by



SESSION C: Interconnections (Auditorium) Integration of III-V GaN amplifiers of an antenna in package receiver in PCB-based embedding technology (Tekfouy LIM, FRAUNHOFER IZM - Germany)	SESSION D: PCB Substrates (Mont Blanc)  Advanced IC substrates – Challenges in the manufacturing and supply chain (Roland STEIM, DYCONEX - Switzerland)
Alternative approach to Die-to-Wafer bonding utilizing atmospheric plasma cleaning (Daniel PASCUAL, ONTOS - USA)	Next Generation Packaging Materials for Challenging AI and Power Electronics Applications (Helmut KRONER, RESONAC - Germany)
Clips bonding using re-metallization techniques (Wilfrid AKLAMAVO, SERMA Microelectronics - France)	High Density Organic Substrates fir Chiplet and High Frequency Application (Lars BOTTCHER, FRAUNHOFER IZM - Germany)
	(Auditorium) Integration of III-V GaN amplifiers of an antenna in package receiver in PCB-based embedding technology (Tekfouy LIM, FRAUNHOFER IZM - Germany)  Alternative approach to Die-to-Wafer bonding utilizing atmospheric plasma cleaning (Daniel PASCUAL, ONTOS - USA)  Clips bonding using re-metallization techniques (Wilfrid AKLAMAVO, SERMA Microelectronics -

## TELEDYNE 62V | Semiconductors

## 12h45 - 13h45 Lunch (Exhibition Hall) sponsored by

	SESSION E: Process Optimization 1 (Auditorium)	SESSION F: Reliability 1 (Mont Blanc)
13h45	An innovative deposition technology for conductive & dielectric materials; Multimaterials, Multilayers, Contactless High-Resolution High-Speed Deposition (Stéphane ETIENNE, I-O-TECH, Israel)	Robustness and environmental impact of under bump metallization for wafer level balling (Arnaud GARNIER, CEA LETI - France)
14h15	SWEET (Side Wall ExquisiteEnveloping Technology) to protect WLSCP (Shih Chieh TANG, ASE group)	SACN doped Mn solder balls oxidation study for BGA's reliability performance (Stelliane GROLIER LEE, STMicroelectronics - France)
14h45	Post plasma dicing clean in Batch spray equipment with sulfuric ozone mixtures (Moritz MITTERMAYR, SICONNEX - Austria)	Experimental study of interfacial adhesion of passivation/resin with shear test: first learnings (Marie DUGOR DENTONE, STMicroelectronics - France)



### 15h15 – 15h45 Exhibition / Coffee break sponsored by

**SESSION G: Dicing / Picking SESSION H: Flip Chip Process** (Auditorium) (Mont Blanc) 15h45 Plasma Singulation of Single Power Diodes Bonded by Development of a dipping process for silver Intermetallic Eutectic Technique sintered flip chip interconnexion (Sabrina ROZA-ORTIZ, PLASMATHERM - USA) (Céline FEAUTRIER, CEA LETI - France) 16h15 Latest approaches of dicing and grinding for Flux less soldering in activated hydrogen semiconductor device manufacturing atmosphere (Benjamin BERNARD, DISCO - Germany) (Jeff BLAIR, SIKAMA - USA) Displacement mechanisms of polymer 16h45 Industrial Approach for Plasma Dicing: Advances and adhesives used in the flip chip interconnected Challenges structures (Lucile BROUSSOUS, STMicroelectronics – France) (Nacer AITMANI, CEA LETI - France)

17h45 – 18h30 Exhibition Hall

17h15

20h00: Dinner - Grenoble downtown

Precision plasma dicing of wafers

(Leslie LEA, PLASMATHERM - USA)

(15 minutes by walk from WTC – 1.4 kms)

#### sponsored by











packaging

Innovative interconnect material for

semiconductor assembly and advanced

(Sze Pei LIM, INDIUM – United Kingdom)



# Thursday June 20th

#### 8h30 - Opening exhibition and conferences

9h10 Keynote: Thomas ROMONT (Senior PCB Expert, IFTEC - France)

IPC Designers Council France - What are our common Challenges for Future?

Session J: Power Management (Auditorium)

Session K: Characterization (Mont Blanc)

**09h45** Understanding Criticality of Thermal

Performance in Thermal Interface Material for

**Automotive Applications** 

(Nicolas RIEM, HENKEL - The Netherlands)

Dual blocks QFN warpage characterization (Federico LEONE, STMicroelectronics - Italy)

**10h15** Packaging and reliability challenges for

Innovative Automative Grade current sensors

(Alastair ATTARD, UTAC - Switzerland)

Die bending methodology to explore Deep Trench Isolation crack initiation risk in Backside Imager Sensors

(Caroline MOUTIN, STMicroelectronics - France)

#### 10h45 - 11h15 Exhibition & Coffee break (Exhibition Hall) sponsored by

Session L: Process Optimization 2

Session M: Sustainability

(Auditorium)

11h15 In Situ characterization of plasma species for process optimization and improvement

(Djamila CHOU, STMicroelectronics - France)

Fabrication of low density3D PCB using piezo-ink jet and 6 axis robots

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(Davide BENNEVENTI, INPG - France)

**11h45** Direct silicon wafer bonding outside cleanroom

conditions

(Tobias BUCHMANN, DTU Electro - Denmark)

High Precision Capillary Printing (HPCAP) and its

(Mont Blanc)

sustainable value in electronics

(Julien VITIELLO, HUMMINK - France)

**12h15** Two steps collective bonding, from dicing-tape

to device over 10000 UPH

(Aurélien GRIFFART, SET - France)

Sustainable and circular PCB using

biobased/biodegradable substrates and metals

bioleaching

(Vincent GRENNERAT, INPG CROMA - France)

THE NEW VALUE FRONTIER

### 12h45 - 13h45 Lunch & Exhibition (Exhibition Hall) sponsored by

KANFEKG

Session N: Molding process (Auditorium)

Environment-friendly Epoxy Molding Compounds for Semiconductors and

Automotive

13h45

14h15

(Takahiro WATANABE, Sumitomo Bakelite Co.

Ltd - Japan)

Session O: Reliability 2 (Mont Blanc)

Enhanced Board Level Reliability Method for High Performance Automotive BGA Packages (Nohora CAICEDO, STMicroelectronics -

France)

Advanced Mold Design Solutions to Counteract Surface Discoloration in Flip Chip Encapsulation

(Shih Kun LO, ASE group - Taiwan)

The Effects of Voids on Solder Joint Reliability in First Level Interconnect

(Sze Pei LIM, INDIUM – United Kingdom)

# Session P: Interposer 2.5D TSV 3D (Auditorium)

**14h55** Design and verification of a 2.5 Heterogeneous Integration Platform

(Jeroen SCHELKENS & Dimitrios TSIAKOS, IMEC - Belgium)

15h25 Unlocking the Trends and Challenges in Advanced 3D Heterogeneous Integration

Manufacturing

(Rayane MAZARI, YOLE Group - France)

**15h50** Hermetically sealed glass interposer platform for photonics integrated circuits

(Kevin KROEHNERT, FRAUNHOFER IZM - Germany)

**16h15** Si Based integrated passive devices for Sub 6G SiP

(Mark AZZOPARDI, JCET group - Switzerland)

#### 16h45 Closing MiNaPAD 2024 Conference by Jean-Marc YANNOU (Auditorium)

#### Address:



#### **World Trade Centre Grenoble**

5-7 place Robert Schuman 38025 Grenoble

http://www.congres-wtcgrenoble.com/

# **List of Exhibitors**

<b>Booth number</b>	Company		
1	IMAPS - PACK4EU		
2	ASE		
3	EMPC - IEEE		
4	NANOTEC		
5	ONTOS		
6	CDS - NAMICS		
7	MICROLIGHT 3D		
8	GS SWISS PCB		
9	ELEMCA		
10	METRONELEC		
11	MICON GLOBAL		
12	KYOCERA		
13	SET		
14	NITERRA		
15	ACCELONIX		
16	AEMTEC		
17	EGIDE		
18	MST		
19	TAIPRO		
20	ISP SYSTEM		
21	BT ELECTRONICS		
22	TELEDYNE E2V		
23	HYBRID		
24	FINETECH		
25	MICROWORLD		
26	SERMA Microelectronics		
27	ELECTRON MEC		
28	HEF Groupe		
29	CEA		
30	SYNERGY CAD		
31	PROTAVIC		
32	DISCO		
33	YOLE		

# **REGISTRATION FORM**

☐ Mrs,	□ M.							
Name:		.Firstname:						
By Post: IMAP		<u>ge.fr</u> miral Hamelin,	Country 75016 Paris					
FEES:								
Students and Teachers (University and Laboratories), retiree: 0 Euro conferences attendance, proceedings, without social event – Registration is mandatory with justification.								
Speakers:  200 € VAT excl.  Please confirm your attendance to social event								
Chairs, Technical Committee:  200 € VAT excl.  Please confirm your attendance to social event								
IMAPS Member IMAPS 2024 and IEEE 2024 Membership  390 € VAT excl.  Please confirm your attendance to social event								
Non IMAPS Member								
O Special Die	et	Vegetarian		O other				
Condition of payment: No refund in case of cancellation VAT not required for non-French Companies    by chèque to IMAPS (France only)   Payment by bank transfer   Registration and Payment on line <a href="https://event.imapsfrance.org">https://event.imapsfrance.org</a>   Purchase order (PO)								

#### **IMAPS BANK REFERENCES**

LCL VERSAILLES ST LOUIS - IBAN FR 49 3000 2089 0007 9088 G25 - Code BIC : CRLYFRPP